Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination LEE, JONG-JIN	
10/617,174		
Examiner	Art Unit	
Tawfik Goma	2653	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (US-PGPUB, USOCR,USPAT, EPO, JPO, DERWENT, IBM_TDB) Text search (see attached)	12/27/2005	TG		
East (US-PGPUB, USOCR,USPAT) (369/53.23).ccls; (369/44.27).ccls	12/27/2005	TG		
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